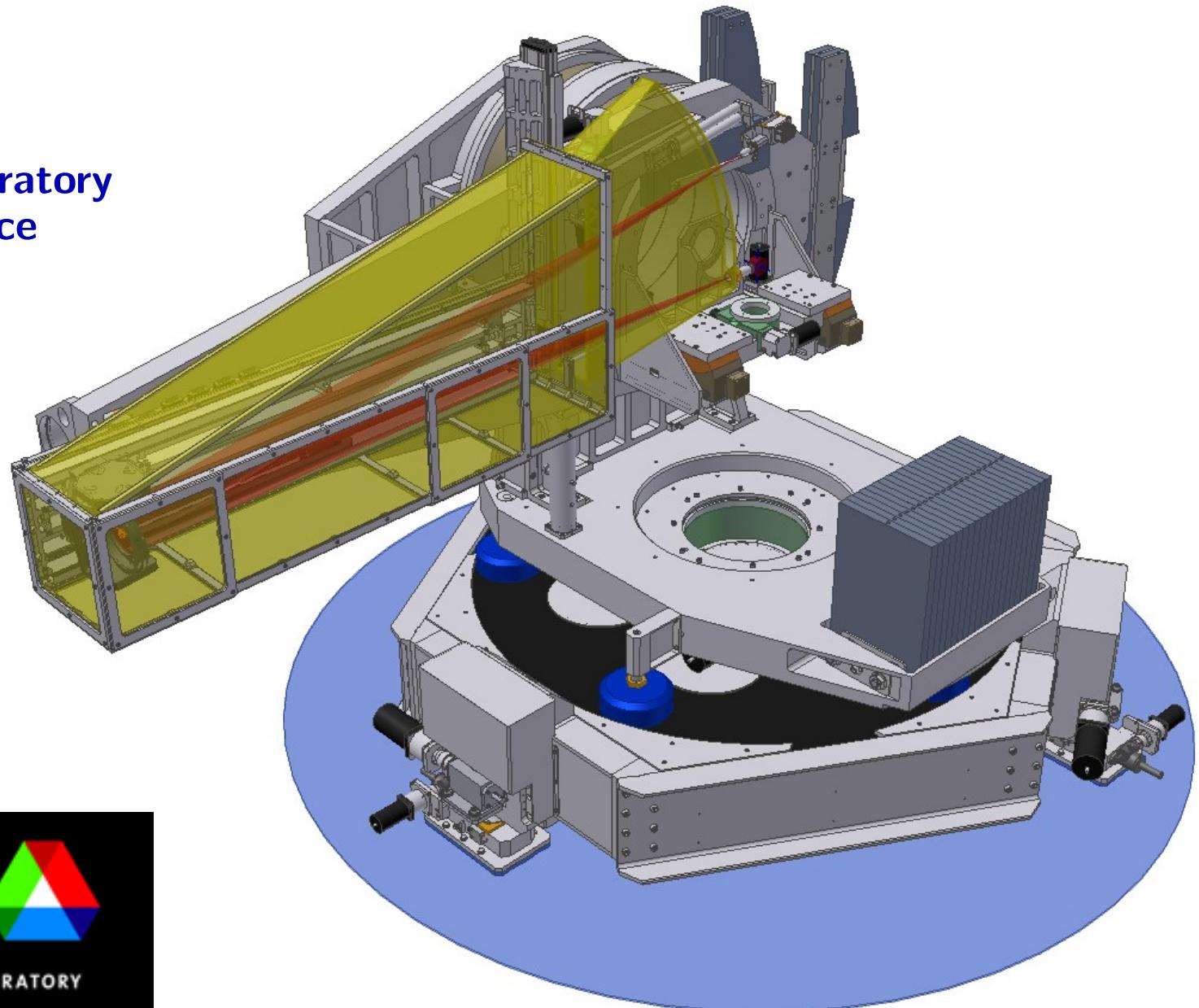


# MERIX Spectrometer

**Yuri Shvyd'ko**

Argonne National Laboratory  
Advanced Photon Source



# MERIX Design Team

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- Clement Burns (WMU)
- Scott Coburn (BNL)
- John Hill (BNL)
- Ayman Said (APS)
- Yuri Shvyd'ko (APS)

Also:

- Ercan Alp, Tim Roberts, Harald Sinn, Wolfgang Sturhahn, Tom Toellner, Hasan Yavas (APS, XSD)
- Kurt Goetze, Xuesong Jiao, Joe Sullivan (APS, AES-BC)
- Bran Brajuskovic, Curt Preissner, Demin Shu (APS, AES-MED)
- Yeldez Amer, Mohan Ramanathan (APS, AES-MIS)
- Ruben Khachatryan, Michael Wieczorek (APS, XSD-OFM)



# Content

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- **Scientific Mission**
- **Overview of the instrument.**  
**Design parameters**
- **November 2006: MERIX commissioning.**  
**Design parameters achieved.**
- **March 2007: X-ray optics and detector developments.**  
**Better energy resolution is achieved.**  
**Count rates increased by a factor of > 10.**
- **Outlook**



# Scientific Mission of MERIX

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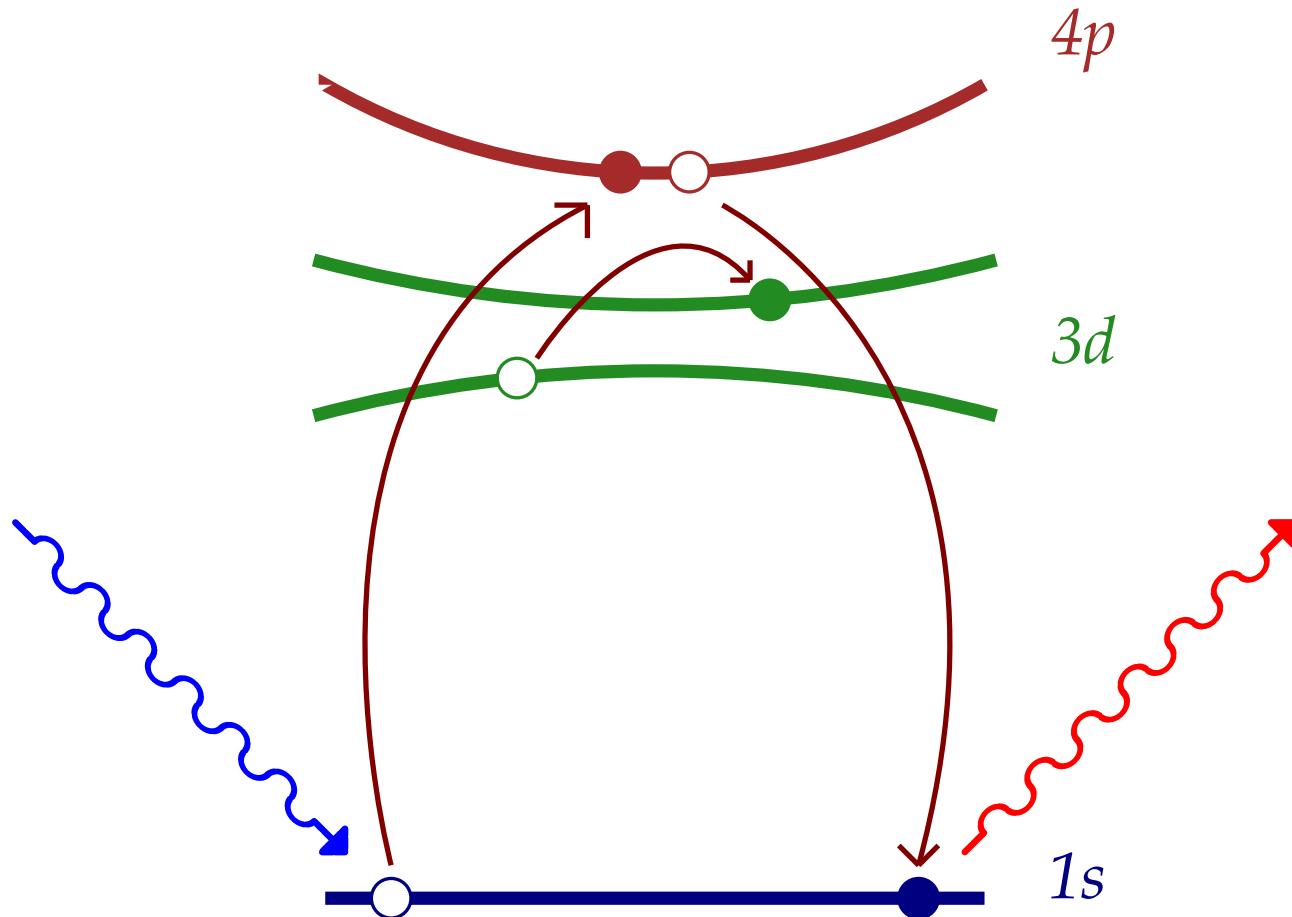
- Purpose: study of electronic excitations.
- Technique: resonant IXS (RIXS) and non-resonant IXS.
- Incident photon energies 4 - 14 keV  
(K-edges of 3d elements, L-edges of 4f elements, M-edges of U).
- Energy resolution about 100 meV.
- Polarization dependence - scattering in horizontal and vertical plane.
- Increased flux and improved analyzer design.
- Sample environments:  
low and high temperatures, high pressure, magnetic field.



# K-edge RIXS

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RIXS: Photon-in Photon-out spectroscopy.  
No charge particles enter or leave the sample.



Energy losses are due to a “shake-up” process of the valence  $3d$  electrons, in between the creation and annihilation of the  $1s - 4p$  core exciton.

# RIXS vs. XAS, PES, ARPES, EELS

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**RIXS: captures the physics of charge dynamics by observation of momentum-dependent excitations across the gap.**

- **Probes excited electronic states  
(charge-transfer,  $d - d$ , etc. excitations)**
- **Momentum-dependent information.**
- **Absence of the deep core hole effects (no lifetime broadening).**
- **Bulk sensitive.**
- **Element specific.**
- **Resonantly enhanced.**
- **Applicable to metals and insulators (photon-in, photon-out).**
- **Allows studies under extreme conditions  
(high pressure, magnetic fields, extreme temperatures, etc.).**



# Scientific Mission of MERIX

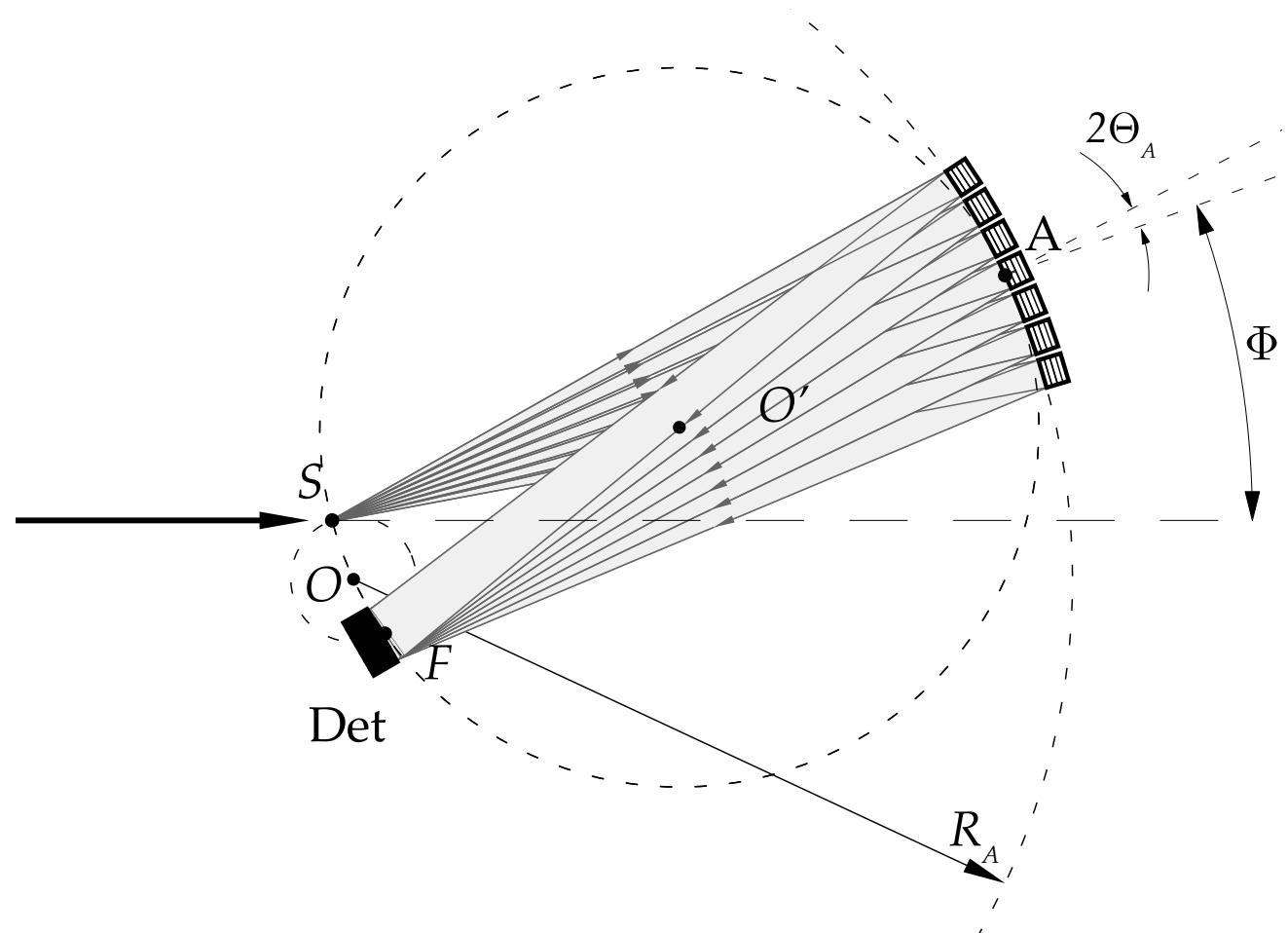
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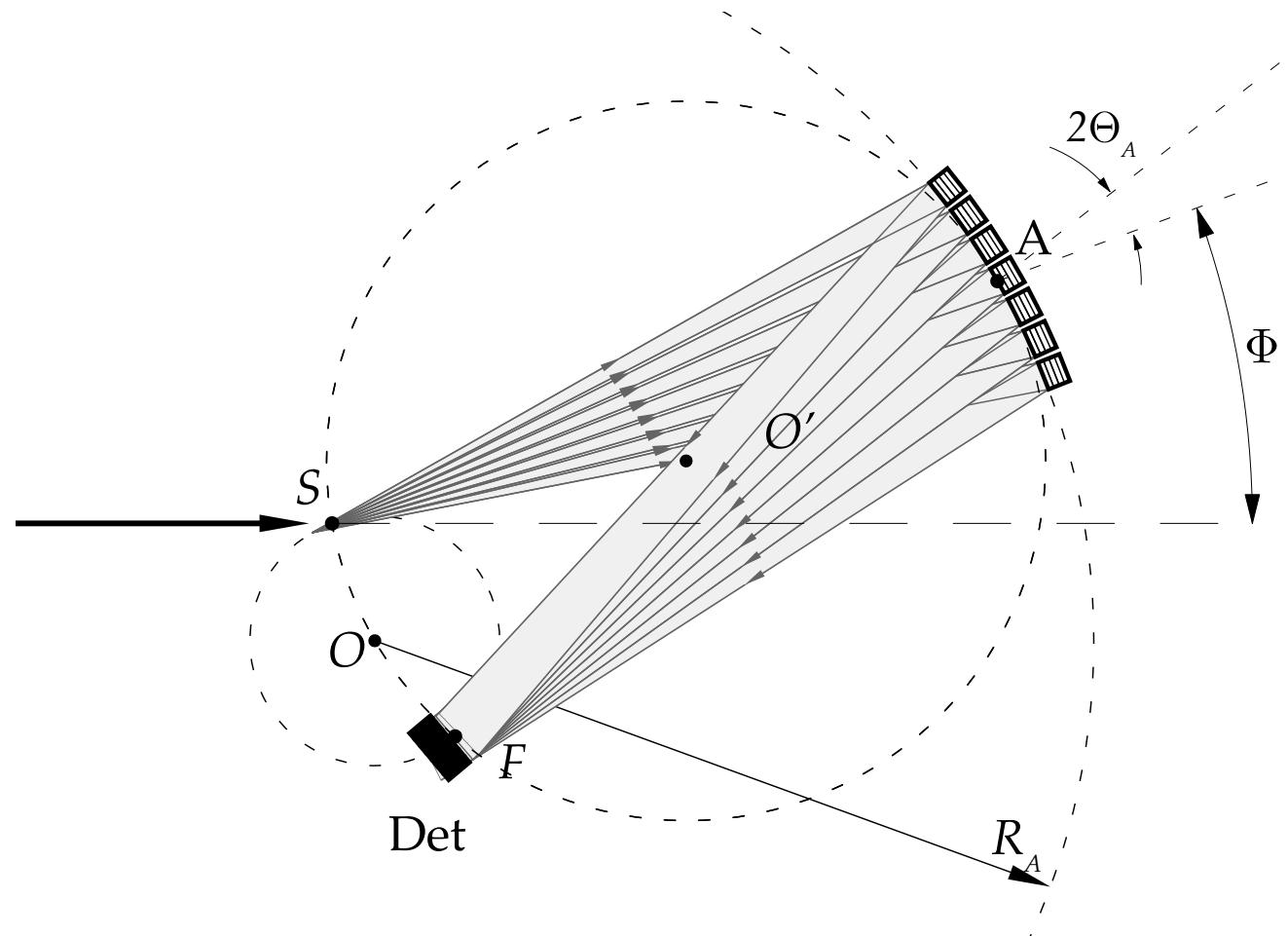
# MERIX optical scheme

Scheme of gathering, focusing, and spectral analysis of x-rays  
by a segmented spherical crystal analyzer.



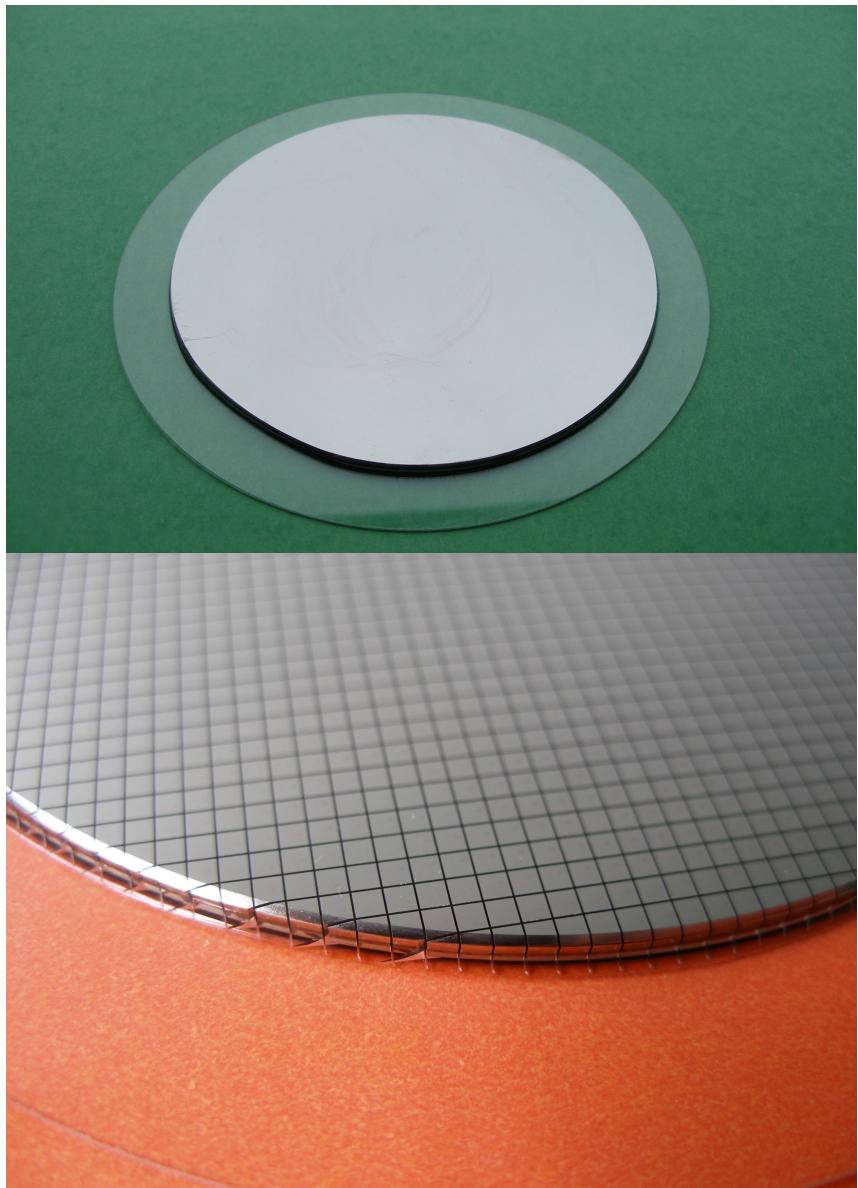
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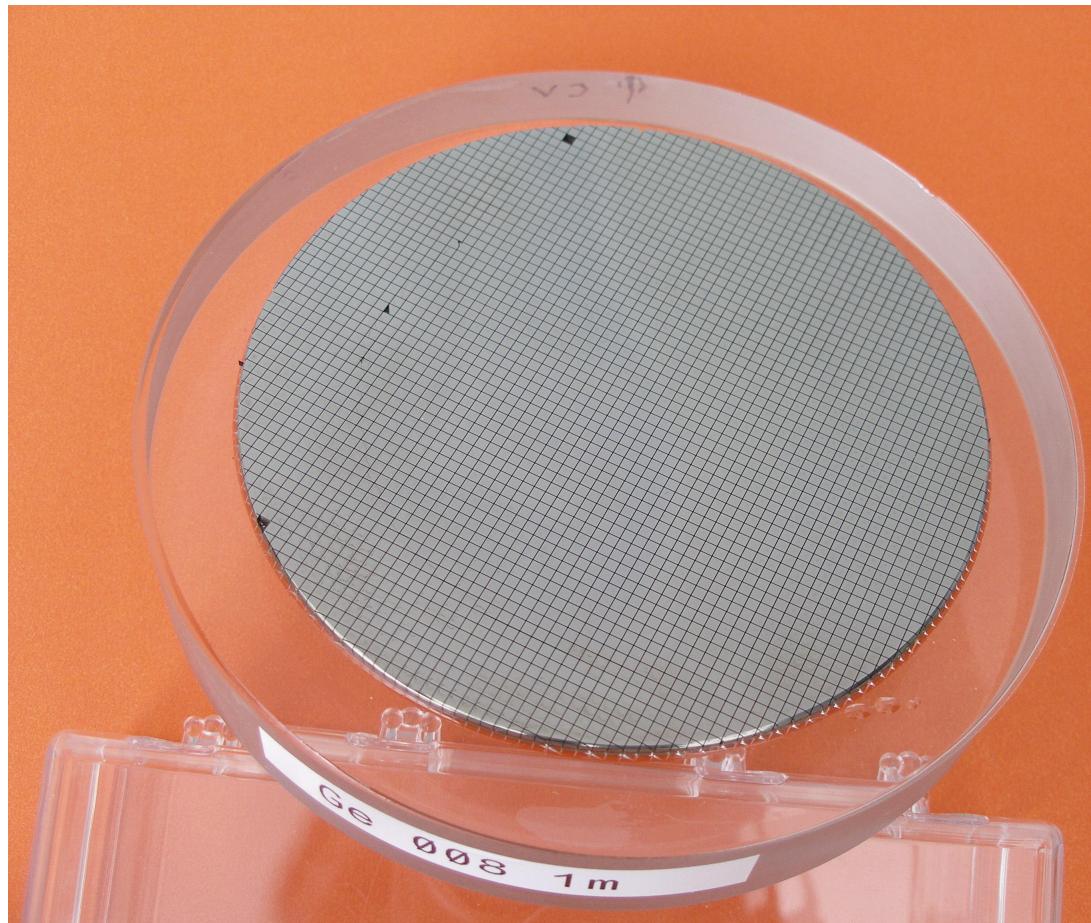


# Analyzer Development and Production

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MERIX Spectrometer



**Ayman Said  
Michael Wieczorek  
Ruben Khachtryan  
Yuri Shvyd'ko**

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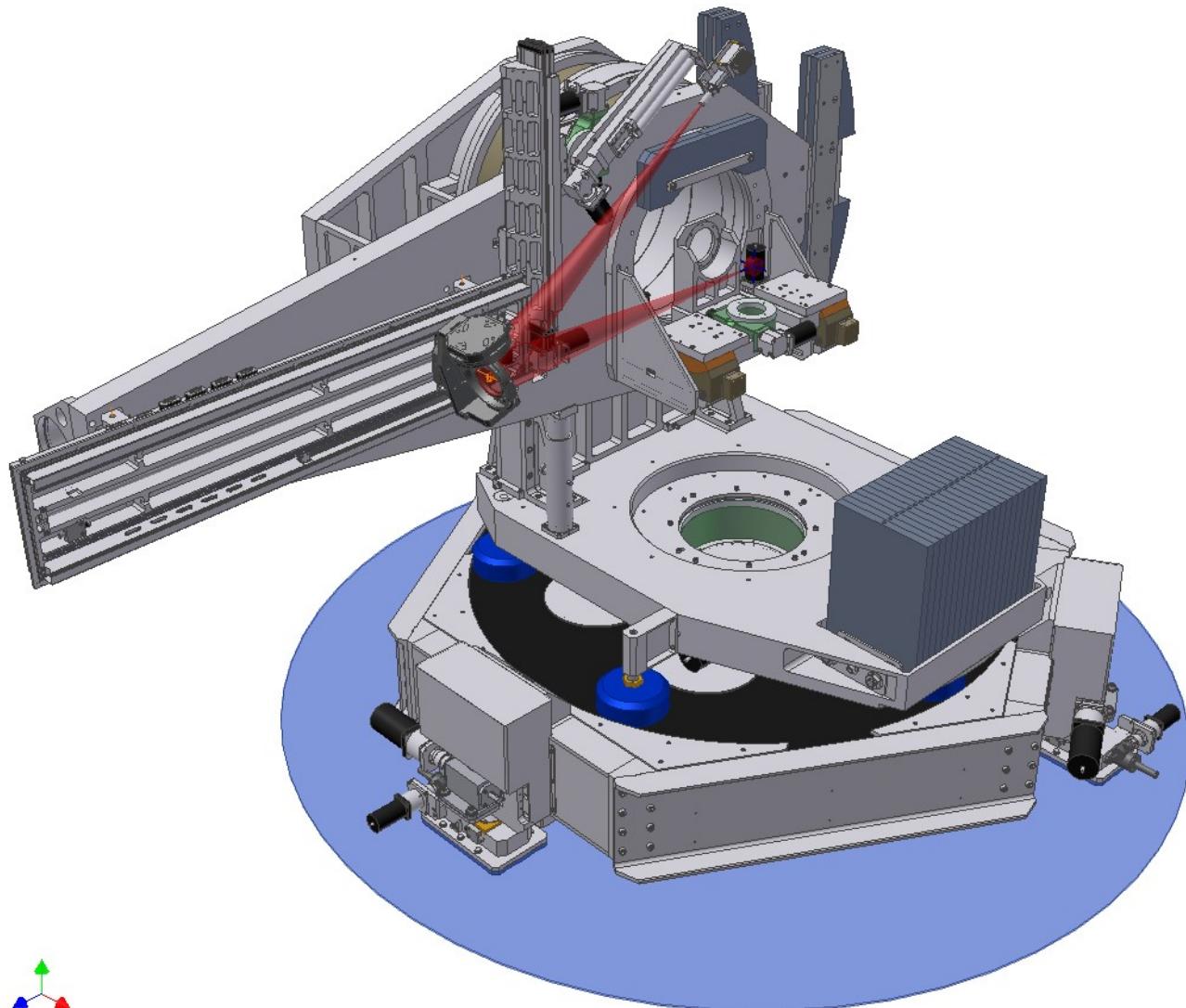
Yuri Shvyd'ko

APS, March 26, 2006

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# MERIX Spectrometer - Design

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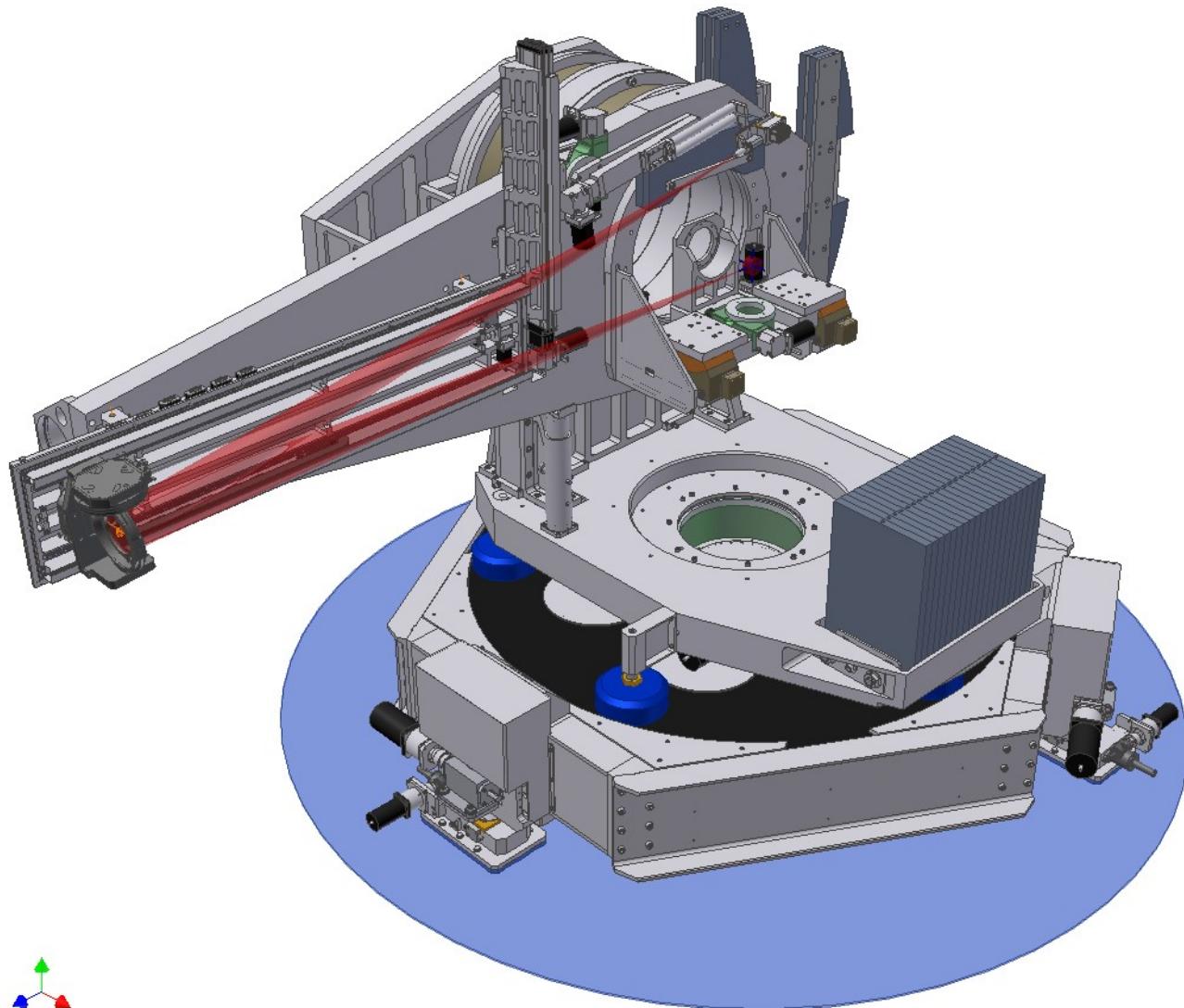


**Scott Coburn  
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# MERIX Spectrometer - Design

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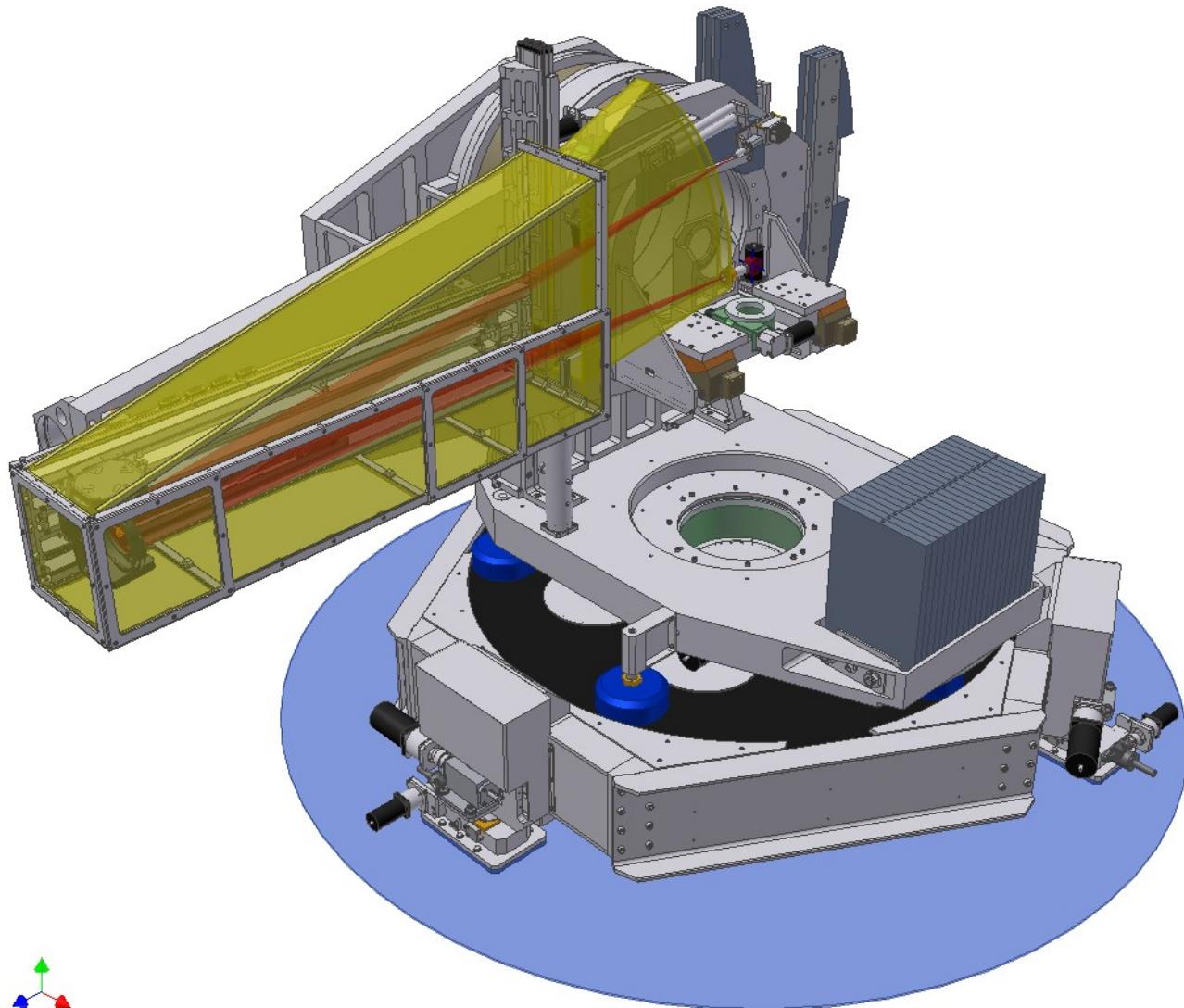


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# MERIX Spectrometer - Design

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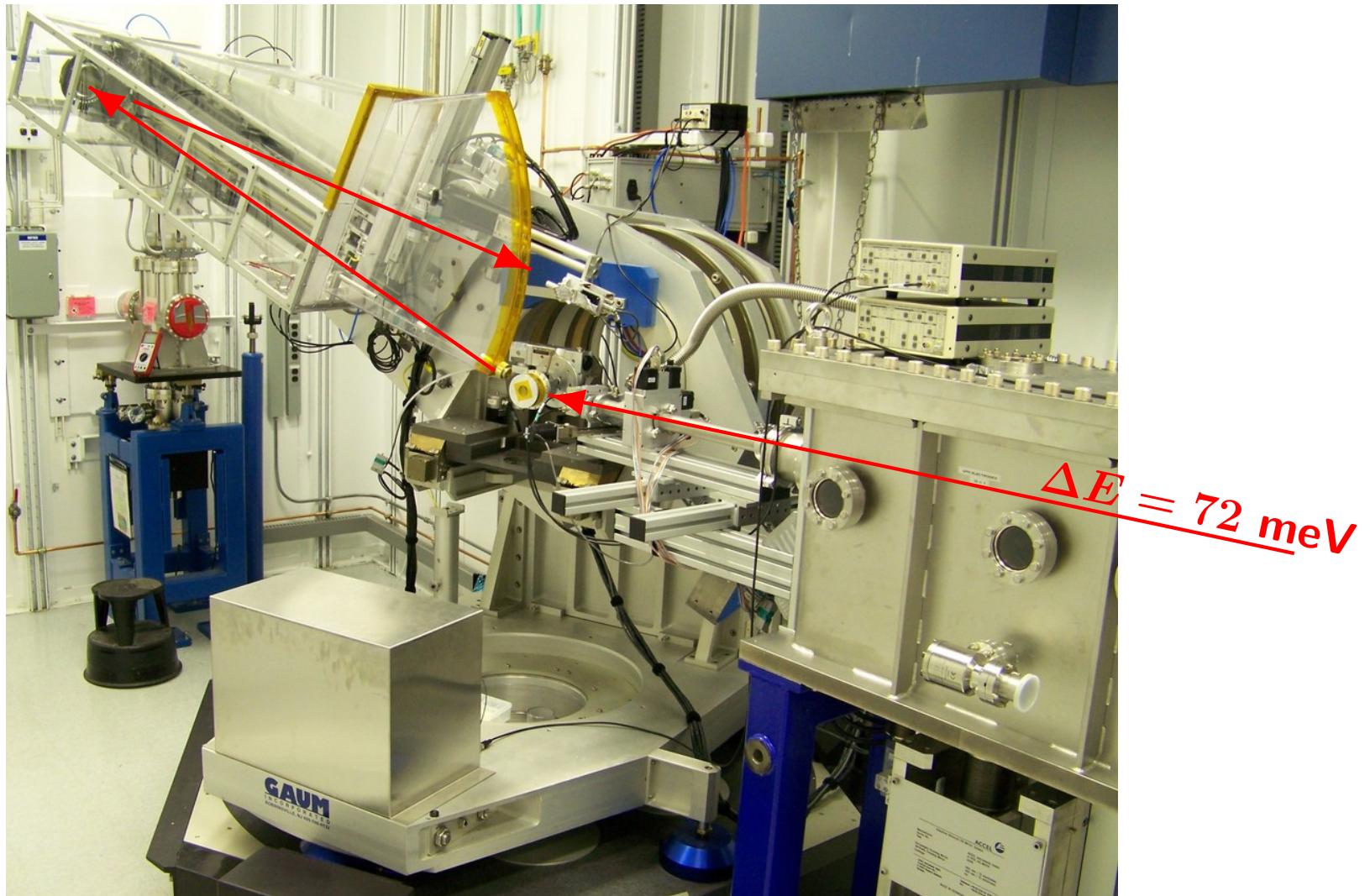
**Scott Coburn  
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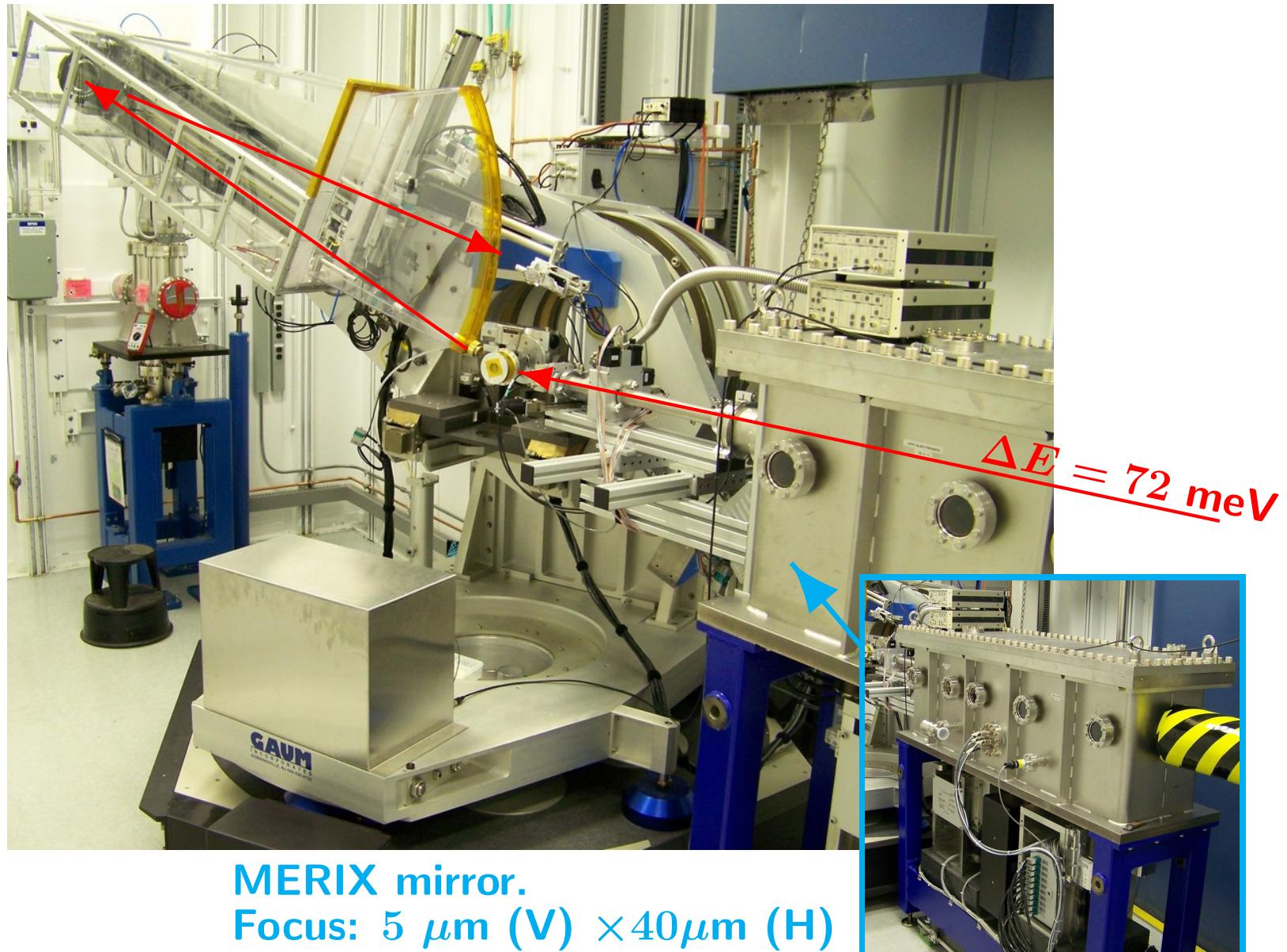
# MERIX Installation History



# MERIX Spectrometer@30-ID.APS, October 2006

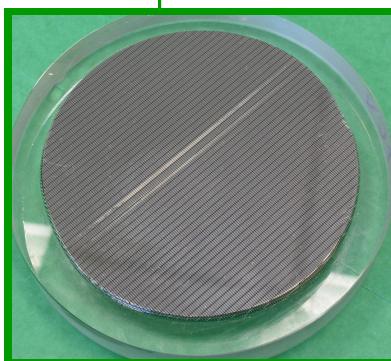


# MERIX Spectrometer@30-ID.APS, October 2006

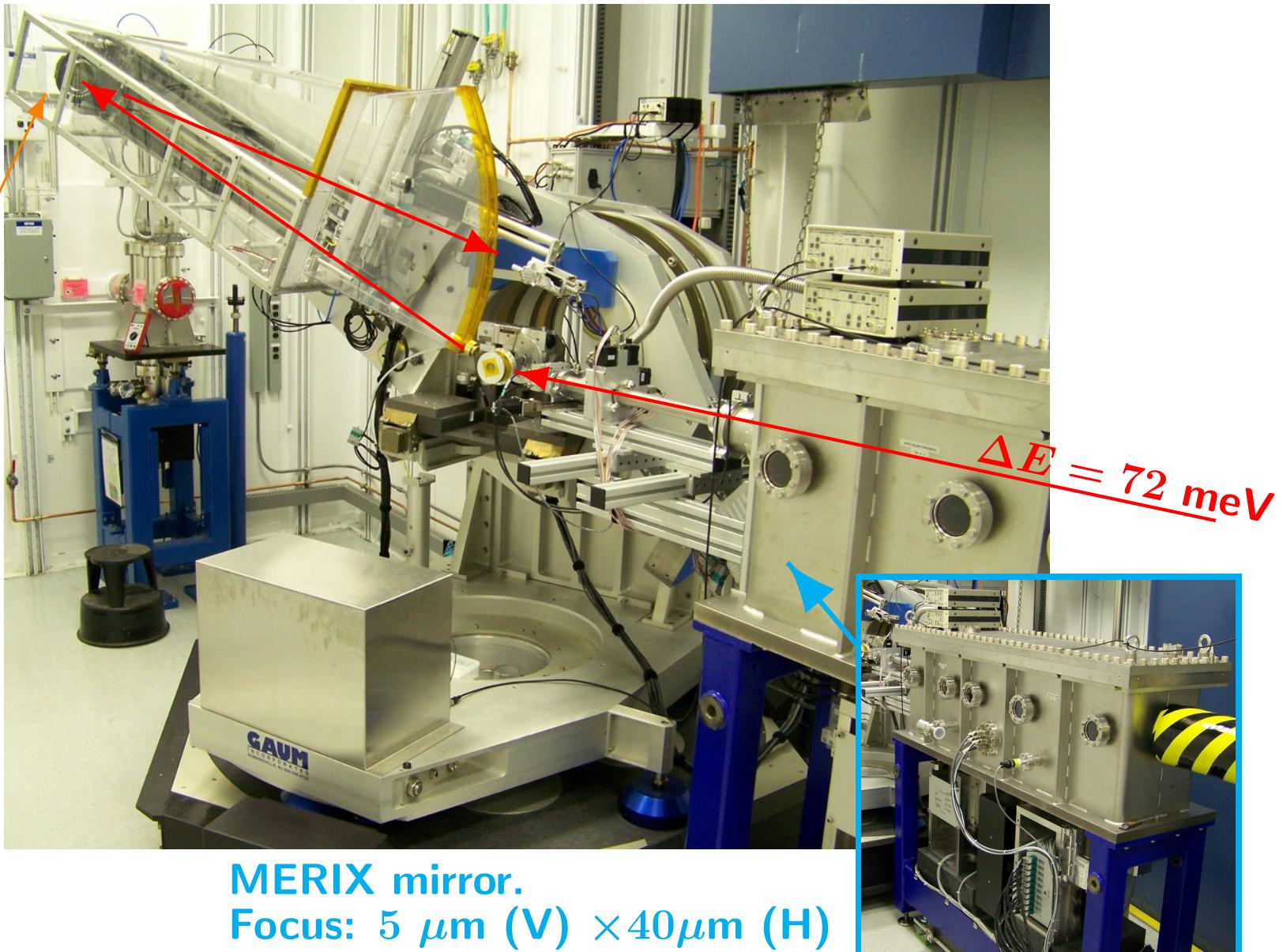


# MERIX Spectrometer@30-ID.APS

Analyzer gimbal



Ge(337)  
diced analyzer:  
 $\Delta E = 115 \text{ meV}$



MERIX mirror.  
Focus:  $5 \mu\text{m} (\text{V}) \times 40 \mu\text{m} (\text{H})$



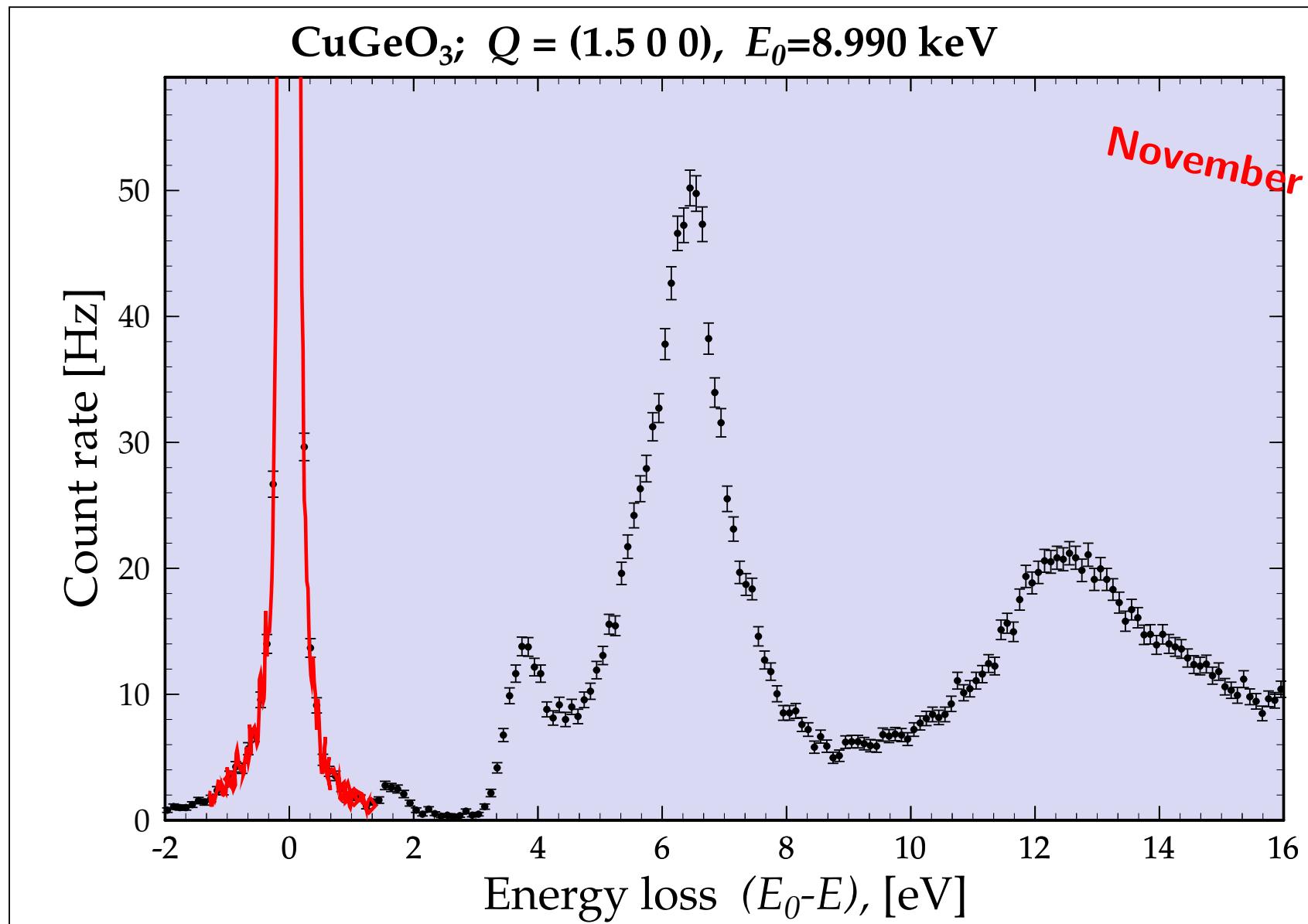
# Design parameters achieved

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Category	design value	de facto
Spectral Flux, main monochromator [photons/s/eV]	$2 \times 10^{13}$	$4 \times 10^{13}$
Spectral Flux, MERIX monochromator [photons/s/100meV]	$1 \times 10^{12}$	$2 \times 10^{12}$
Tunability [keV]	<b>5-12</b>	<b>4.5 - 14</b>
Beam size on MERIX sample [ $\mu\text{m} \times \mu\text{m}$ ]	<b>20 × 40</b>	<b>6 × 45</b>
Ge(337) Cu K-edge analyzer	<b>1</b>	<b>1</b>
Overall energy resolution [meV]	<b>120</b>	<b>100-130</b>



# First RIXS Spectrum Measured with MERIX



# February 2007: User Operations Started

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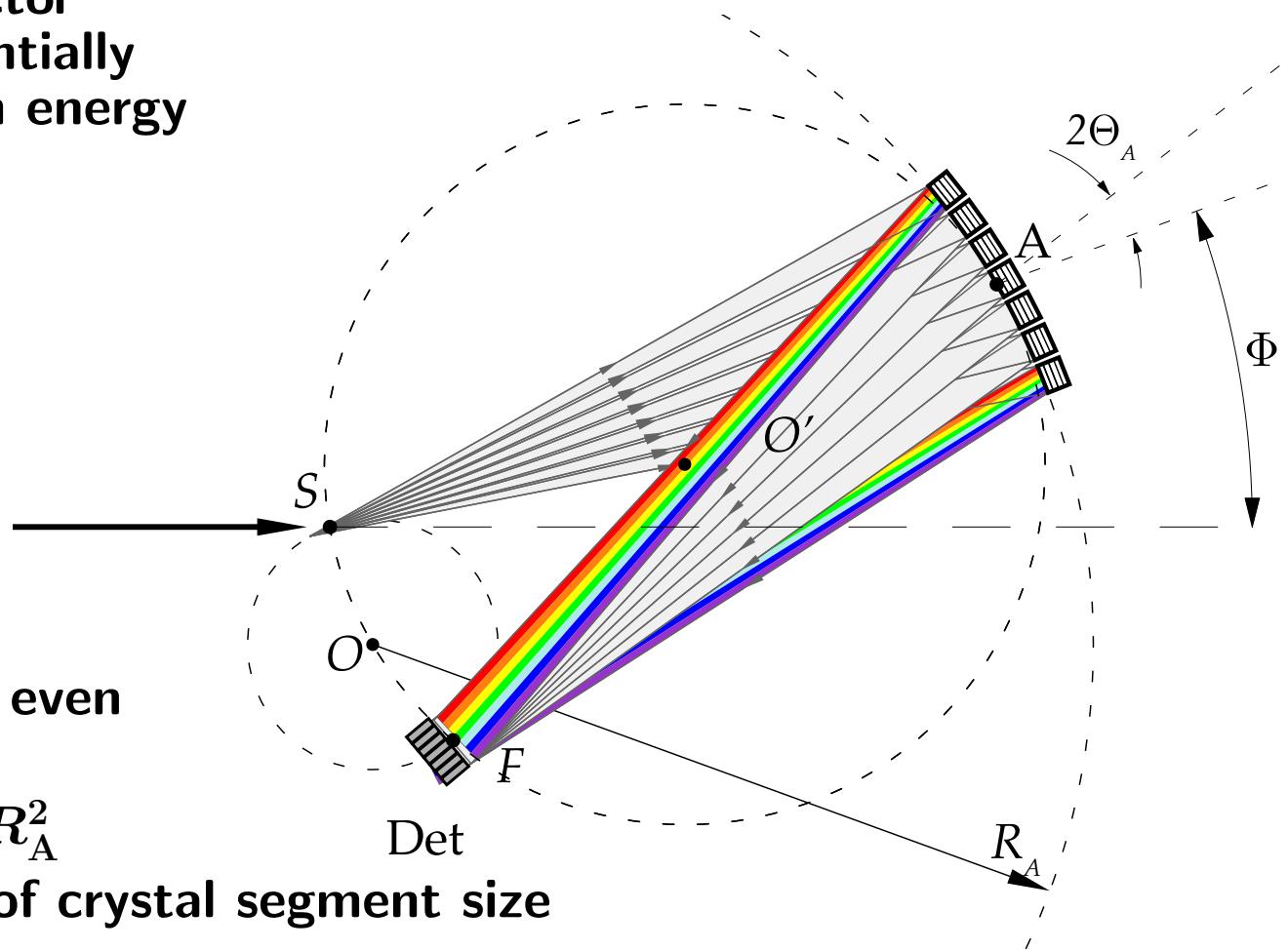
**Happy first users:**  
**Daniele Antonangeli**  
**Daniel Farber**  
**(LLNL)**  
**with**  
**Ayman Said**



# Next generation x-ray optics and detectors for IXS

S. Houtari et al. (2005) :

Use position sensitive detector  
to detect IXS signal differentially  
in space and thus in photon energy



## Implications for MERIX:

1. Better energy resolution even with smaller  $R_A$
2. Higher countrates  $\propto 1/R_A^2$
3. Resolution independent of crystal segment size



# Photon-Counting Si Microstrip Detector

D. Peter Siddons, Brookhaven



640 strips  
1 strip =  $125 \mu\text{m}$   
1 strip =  $40 \text{ meV}$   
640 strip =  $25 \text{ eV}$



Donated to IXS-CDT by Steve Cramer, UC Davis



MERIX Spectrometer

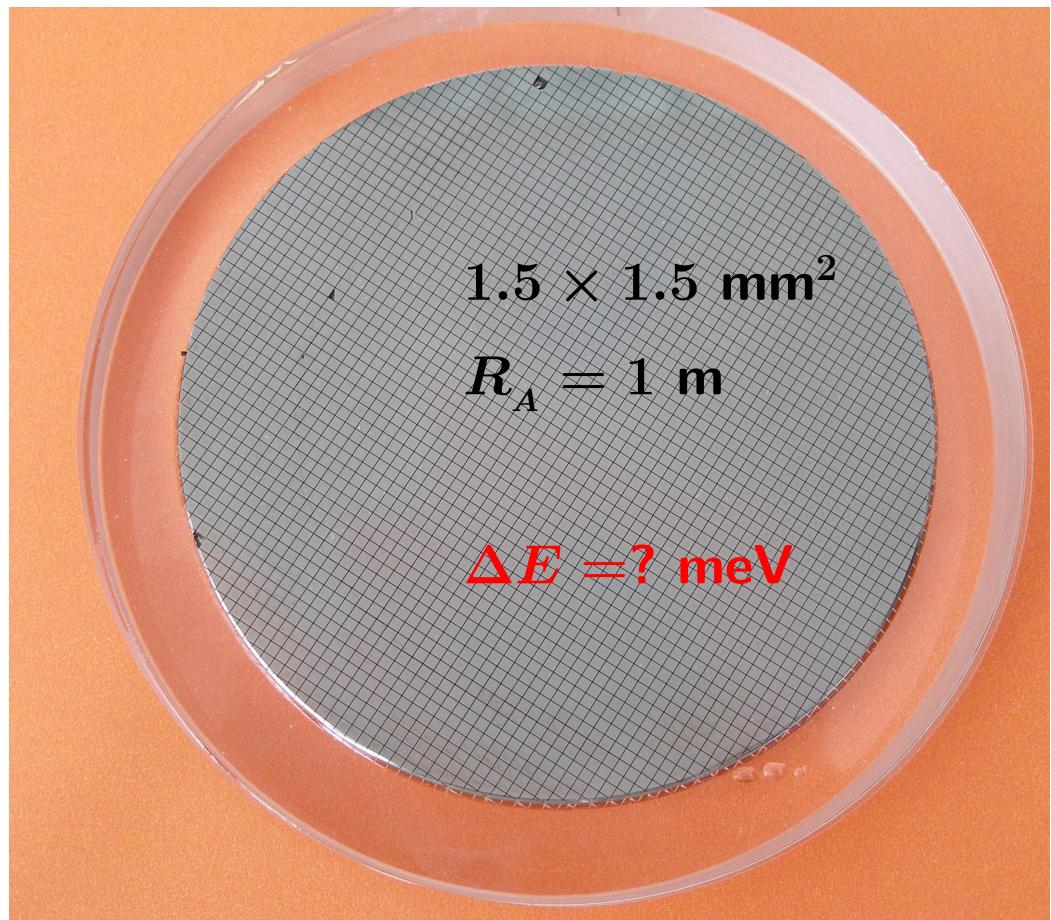
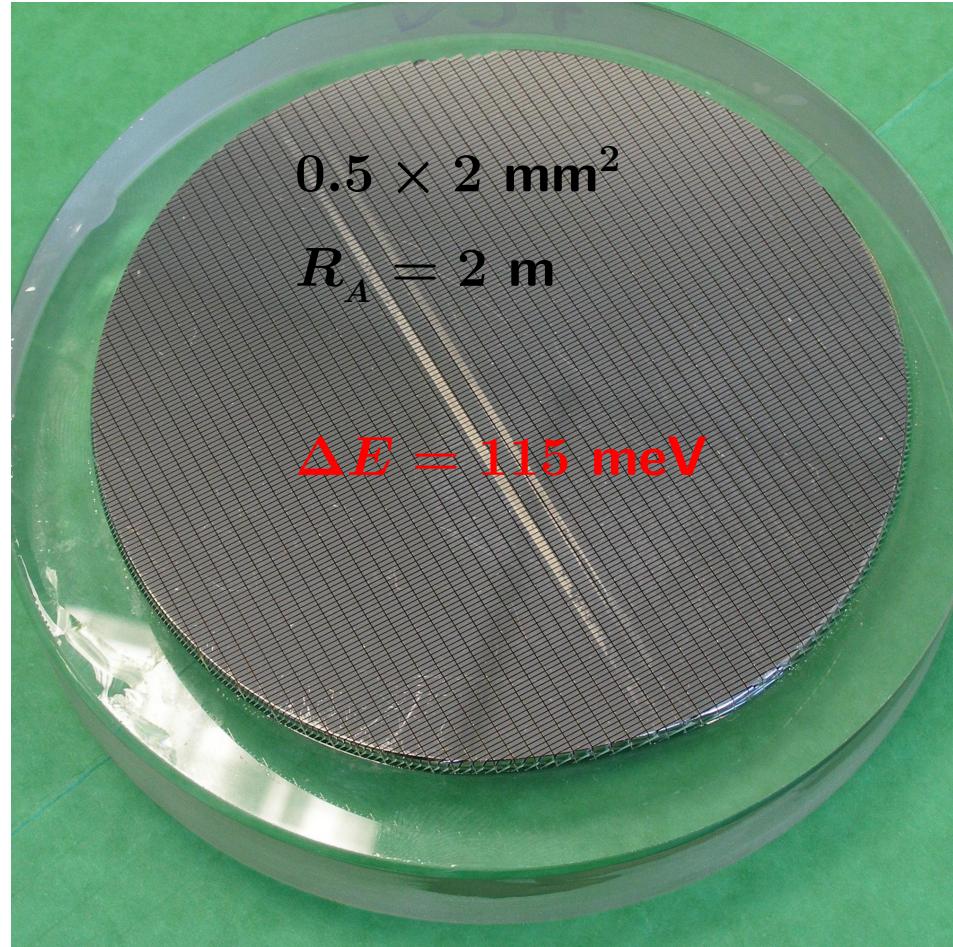
Yuri Shvyd'ko

APS, March 26, 2006

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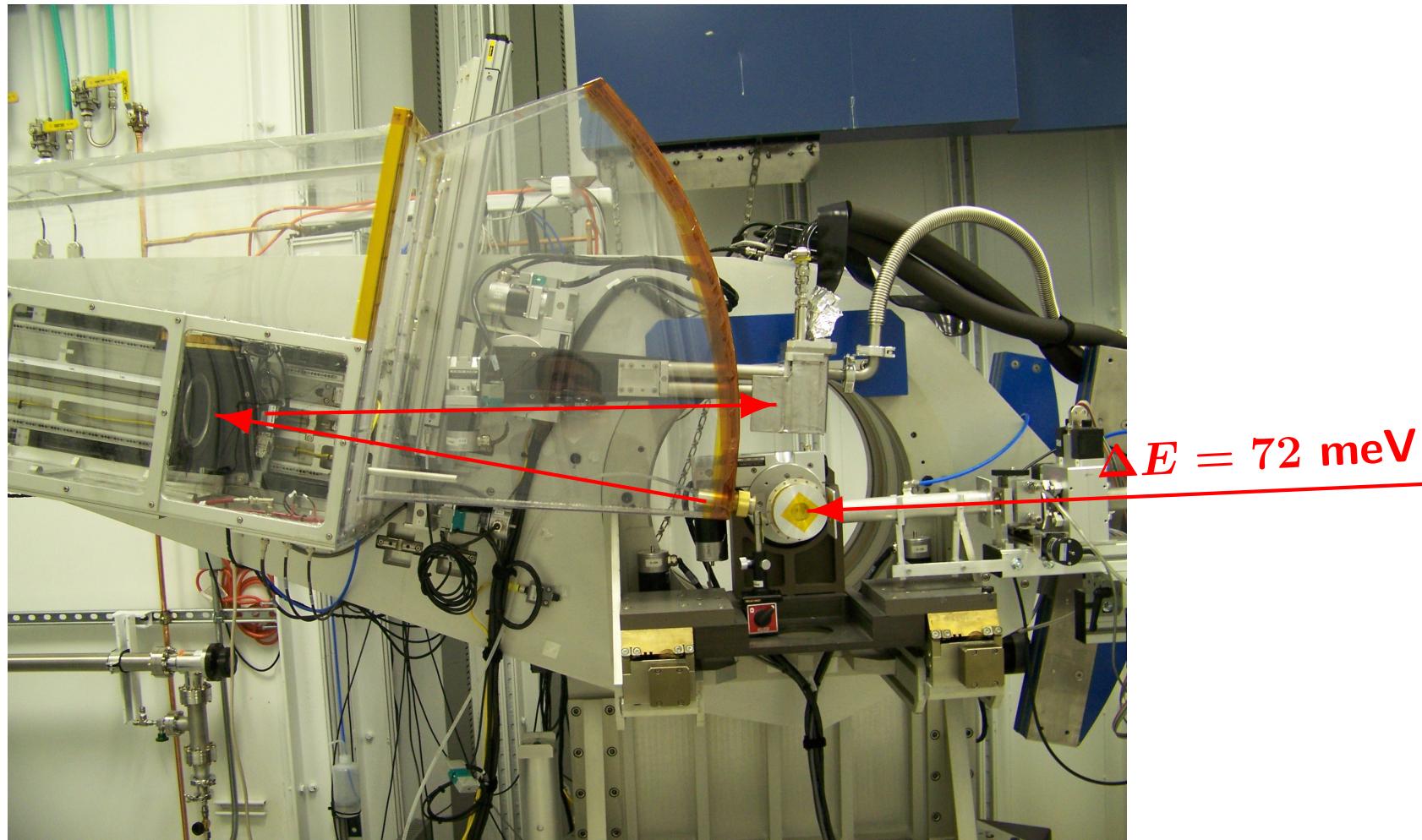
# Analyzers with bigger crystal segments

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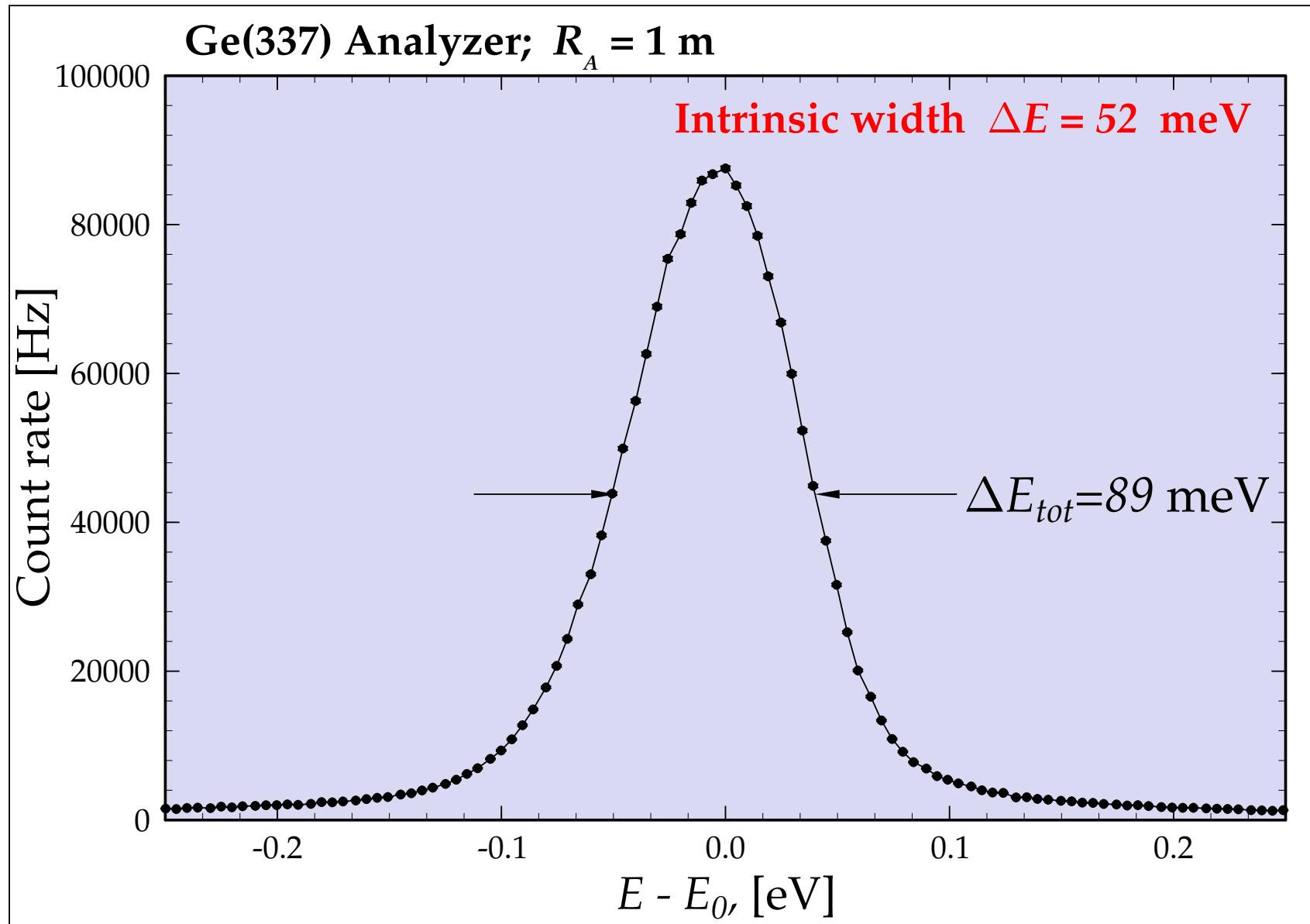


# MERIX Spectrometer@30-ID.APS, March 2007

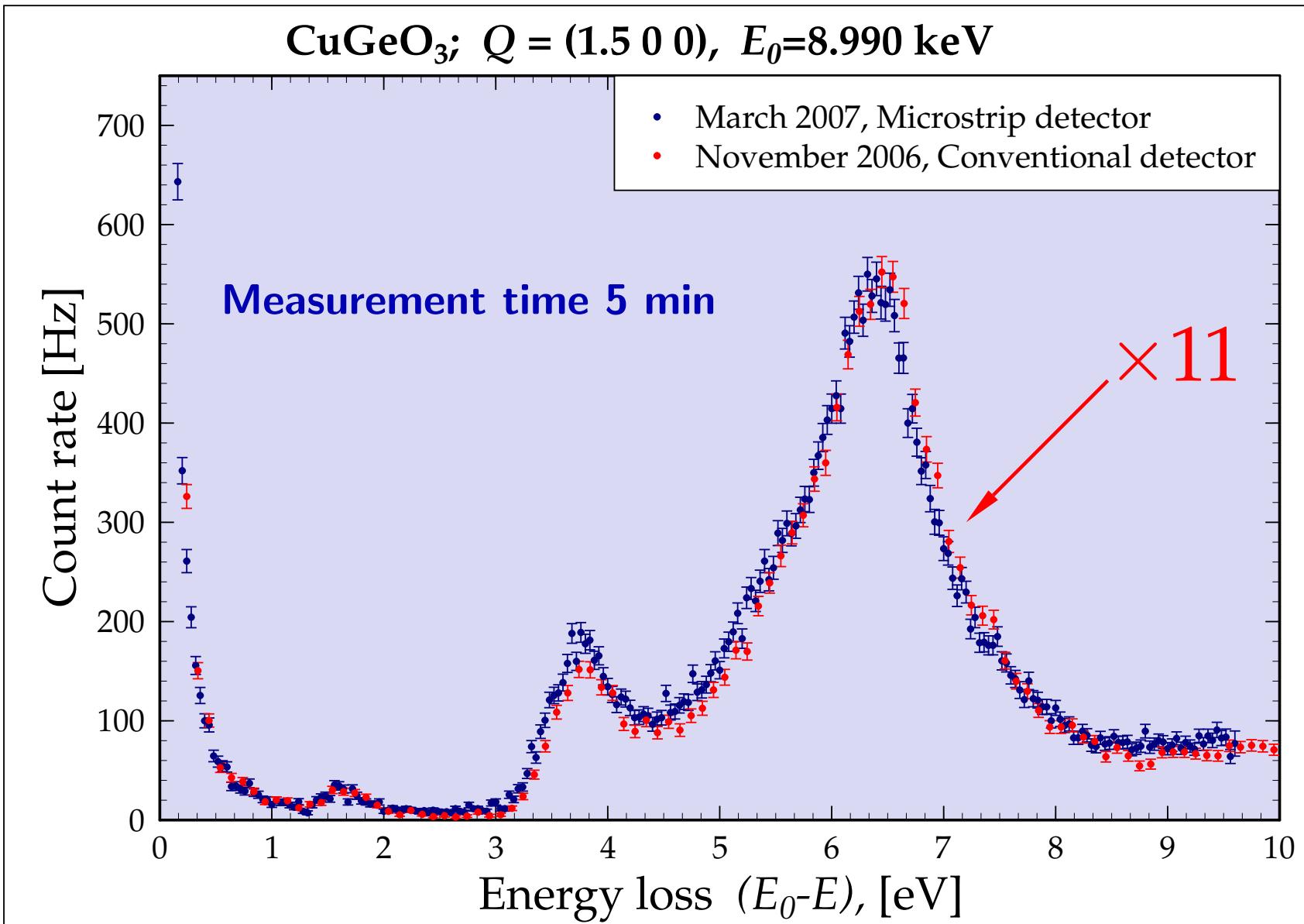
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# Energy resolution



# Dramatic Increase in Count Rate



# Conclusions

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- November 2006: MERIX design parameters are achieved.
- February 2007: User operations started.
- Next generation x-ray optics and detector is tested:
  1. Narrower spectral function (90 meV)
  2. Count rates increased by a factor of  $> 10$ .
  3. Cu and Co K-edge analyzers are tested.
- Analyzer tests and development in progress for  
V, Mn, Cr, Fe, Ni (K-edge)  
Eu, Yb (L-edge)



# RIXS Analyzers @ Sector 30

tested

exist

in production

Element	$E$ [keV]	Crystal	Reflec- tion	$\Delta E_i$ intr. [meV]	$\Delta E_g$ geom. [meV]	$\Delta E_{tot}$ total [meV]
V(O)	5.480	LiNbO <sub>3</sub>	( 0 0 0 12)	109	71	130
Cr(O)	6.009	Si	( 5 1 1)	52.2	61	81
Mn(O)	6.555	Si	( 0 4 4)	62	72	95
Fe(O)	7.130	Ge	( 6 2 0)	115	108	158
Co(O)	7.720	LiNbO <sub>3</sub>	( 3 3 6 6)	49	36	60
Ni(O)	8.345	LiNbO <sub>3</sub>	( 0 6 6 0)	50	19	54
		Ge	( 2 4 6)	76	99	123
Cu(O)	8.990	Ge	( 3 3 7)	42	41	59
Eu	6.977	Ge	( 6 2 0)	112	51	123
Yb	8.944	Ge	( 0 0 8)	64	131	145

